## Application/Control No. Applicant(s)/Patent Under Reexamination 10/826,800 SNYDER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 David Nhu 2818 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2001/0046597 A1 11-2001 Weihs et al. 428/336 Α US-6,860,419 B2 03-2005 Simon, Jonathan 228/234.3 В Weihs et al. 204/192.12 US-6,736,942 B2 05-2004 С 05-2001 438/119 D US-6,232,150 B1 Lin et al.

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